

Notice of References Cited	Application/Control No. 10/589,060		Applicant(s)/Patent Under Reexamination WANG, YE-KUI	
	Examiner JONATHAN WILLIS		Art Unit 2441	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,738,390	06-2010	Rey et al.	370/252
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
*	U	Title: "The Error Concealment Feature in the H.26L Test Model"	Author: Wang et al.	Pub: IEEE	Date: 2002
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.